

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under

Reexamination

YUKAWA ET AL.

Examiner

SATHAVARAM I. REDDY

Art Unit

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**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-5,866,236	02-1999	Faykish et al.	428/195.1
*	B US-5,812,316	09-1998	Ochi et al.	359/530
*	C US-5,714,223	02-1998	Araki et al.	428/68
*	D US-2005/0179253	08-2005	Rivera et al.	283/081
*	E US-5,342,821	08-1994	Pearce, Glenn T.	503/227
*	F US-6,261,994	07-2001	Bourdelais et al.	503/227
*	G US-2005/0148469	07-2005	Yukawa et al.	503/227
*	H US-4,663,213	05-1987	Bailey et al.	428/204
*	I US-5,069,964	12-1991	Toliver et al.	428/325
*	J US-2002/0149658	10-2002	Furukawa, Ken-ichi	347/101
*	K US-7,504,147	03-2009	Hannington, Michael	428/143
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	
V	
W	
X	

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